

N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)}	Package	I _D T _A = +25°C	
60V	3Ω @ V _{GS} = 10V	SOT323	300mA	
60 V	4Ω @ V _{GS} = 5V	501323	260mA	

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc

Features

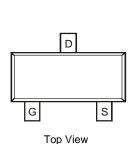
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Small Surface Mount Package
- ESD Protected Gate, 1KV (HBM)
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Qualified to AEC-Q101 Standards for High Reliability

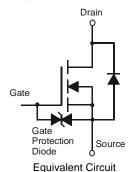
Mechanical Data

- Case: SOT323
- Case Material: Molded Plastic. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish annealed over Alloy 42 leadframe (Lead Free Plating). Solderable per MIL-STD-202, Method 208
- Terminal Connections: See Diagram
- Weight: 0.006 grams (approximate)





Pin Configuration



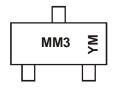
Ordering Information (Note 4)

Part Number	Case	Packaging	
DMN65D8LW-7	SOT323	3000/Tape & Reel	

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



MM3 = Product Type Marking Code YM = Date Code Marking Y = Year (ex: Y = 2011) M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Υ		Z		Α	E	3	С		D		Е
-			ė.		ė.	•				à.		
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	60	V		
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Drain Current (Note 6) V _{GS} = 10V	I _D	300 230	mA		
Continuous Drain Current (Note 6) V _{GS} = 5V	I _D	260 210	mA		
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	800	mA		
Maximum Body Diode Continuous Current (Note 6)	I _S	1	A		

Thermal Characteristics

Characteristic		Symbol	Value	Units	
Total Bower Dissination	(Note 5)	р	300	mW	
Total Power Dissipation	(Note 6)	P_{D}	432		
Thermal Desigtance, Junction to Ambient	(Note 5)	5	398	,	
Thermal Resistance, Junction to Ambient	(Note 6)	$R_{ hetaJA}$	290	°C/W	
Thermal Resistance, Junction to Case	(Note 5)	$R_{\theta JC}$	142		
Operating and Storage Temperature Range		$T_{J_i} T_{STG}$	-55 to +150	°C	

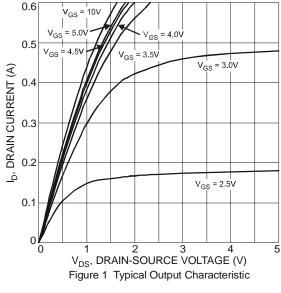
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Tyrn	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)	Symbol	IVIIII	Тур	IVIAX	Onit	rest Condition	
Drain-Source Breakdown Voltage	BV _{DSS}	60	_		V	Vac - 0V In - 250uA	
				1.0		$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}				μA	$V_{DS} = 60V, V_{GS} = 0V$	
Gate-Body Leakage	I _{GSS}			±5.0	μA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)	1		ı	1			
Gate Threshold Voltage	V _{GS(th)}	1.2	_	2.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	
Static Drain-Source On-Resistance	Pro (ON)	_	2	3	Ω	$V_{GS} = 10V, I_D = 0.115A$	
Static Drain-Source On-Nesistance	R _{DS} (ON)	_	2.5	4	Ω	$V_{GS} = 5V, I_D = 0.115A$	
Forward Transconductance	g FS	80	290	_	mS	$V_{DS} = 10V, I_D = 0.115A$	
Diode Forward Voltage	V_{SD}	-	0.8	1.2	V	$V_{GS} = 0V, I_{S} = 115mA$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	_	22.0	_			
Output Capacitance	Coss	_	3.2	_	pF	$V_{DS} = 25V, V_{GS} = 0V, f = 1.0MHz$	
Reverse Transfer Capacitance	C _{rss}	_	2.0	_			
Gate Resistance	R_{G}	_	79.9	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge V _{GS} = 10V	Qg	_	0.87	_			
Total Gate Charge V _{GS} = 4.5V	Qg	_	0.43	_	nC	$V_{GS} = 10V, V_{DS} = 30V,$	
Gate-Source Charge	Q_{gs}	_	0.11	_	iiC	I _D = 150mA	
Gate-Drain Charge	Q_{gd}		0.11	_			
Turn-On Delay Time	t _{D(on)}	_	2.7	_			
Turn-On Rise Time	t _r	_	2.8	_	nS	$V_{DD} = 30V$, $I_D = 0.115A$, $V_{GEN} = 10V$,	
Turn-Off Delay Time	t _{D(off)}	_	12.6	_	113	$R_{GEN} = 25\Omega$	
Turn-Off Fall Time	t _f		7.3	_			

Notes:

- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper pad layout.
 7 .Short duration pulse test used to minimize self-heating effect.
 8. Guaranteed by design. Not subject to production testing.





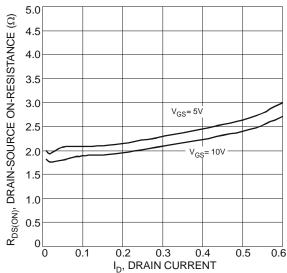
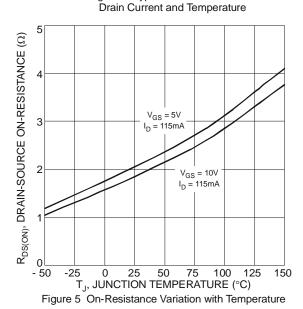
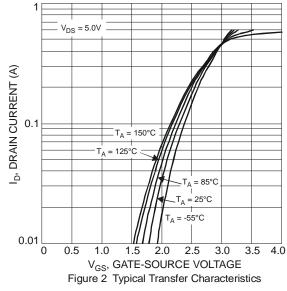


Figure 3 Typical On-Resistance vs.





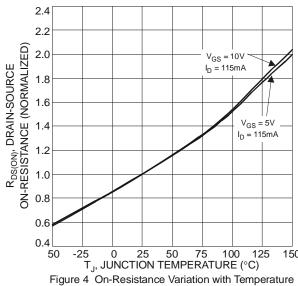


Figure 4 On-Resistance Variation with Temperature

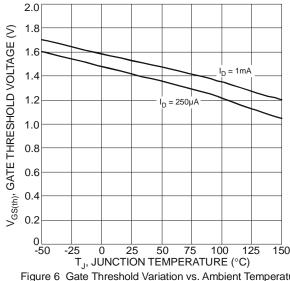
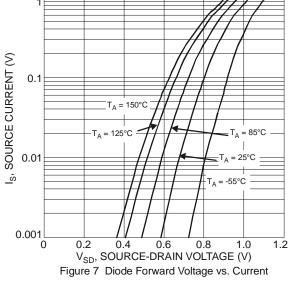
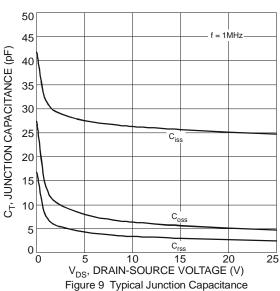


Figure 6 Gate Threshold Variation vs. Ambient Temperature







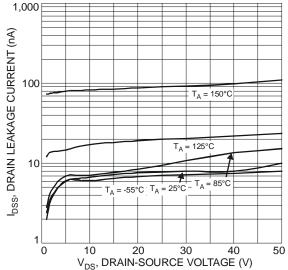
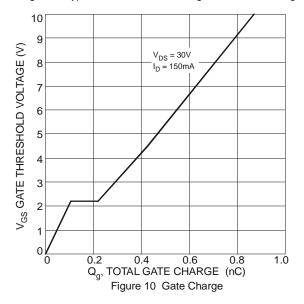
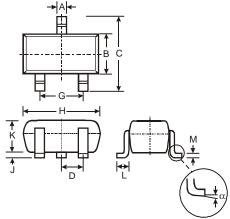


Figure 8 Typical Drain-Source Leakage Current vs. Voltage



Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.

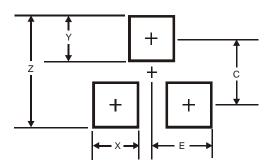


SOT323							
Dim	Min	Max	Тур				
Α	0.25	0.40	0.30				
В	1.15	1.35	1.30				
C	2.00	2.20	2.10				
D	-	-	0.65				
G	1.20	1.40	1.30				
Η	1.80	2.20	2.15				
J	0.0	0.10	0.05				
K	0.90	1.00	1.00				
L	0.25	0.40	0.30				
М	0.10	0.18	0.11				
α	0°	8°	-				
All Dimensions in mm							



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.8
Х	0.7
Υ	0.9
С	1.9
E	1.0

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